

#### **Product Change Notification - RMES-22VSYL025**

Date:	

09 Dec 2019

#### **Product Category:**

Wireless IC

#### Affected CPNs:



#### **Notification subject:**

CCB 3007.002 Final Notice: Qualification of MPHL as an additional Final Test site for selected Atmel ATSAMR30E18A and ATSAMR30G18A device families.

#### **Notification text:**

#### **PCN Status:**

Final notification.

#### **PCN Type:**

Manufacturing Change

#### **Microchip Parts Affected:**

Please open one of the icons found in the Affected CPNs section above.

NOTE: For your convenience Microchip includes identical files in two formats (.pdf and .xls).

#### **Description of Change:**

Qualification of MPHL as an additional Final Test site for selected Atmel ATSAMR30E18A and ATSAMR30G18A device families.

#### Pre Change:

Tested at ASE9 final test site.

#### **Post Change:**

Tested at ASE9 or MPHL final test site.

**Pre and Post Change Summary:** 

i ic and i ost c	-	Pre Change	Post (	Change		
Final test site		ASE Test	ASE Test	Microchip Technology Operations (Philippines)		
Final te	est site	(ASE9)	(ASE9)	Corporation		
				(MPHL)		
Base	Tray	416	416	416		
Quantity Multiple (BQM)	Tape and Reel	4000	4000	4000		
Pin 1	Tray		No change			
	Tape and					
Orientation	Reel	(See attached Pre and Post comparison)				
Tray dir	nension		No change	_		



	Minor Dimensional Changes
Carrier dimension	
	(See attached Pre and Post comparison)
	Minor Dimensional Changes
Plastic reel	
	(See attached Pre and Post comparison)
Other packing information	See attached Pre and Post comparison

#### Impacts to Data Sheet:

None

#### **Change Impact:**

None

#### **Reason for Change:**

To improve on-time delivery performance by qualifying MPHL as an additional Final Test site.

#### **Change Implementation Status:**

In Progress

#### **Estimated First Ship Date:**

January 9, 2020 (date code: 2002)

NOTE: Please be advised that after the estimated first ship date customers may receive pre and post change parts.

Time table Summary:

	1	love	mbeı	201	9	De	cemb	oer 20	)19		Jan	uary 2	2020	
Workweek	44	45	46	47	48	49	50	51	52	1	2	3	4	5
Initial PCN Issue Date			X											
Qual Report Availability							X							
Final PCN Issue Date							X							
Estimated											<b>&gt;</b>			
Implementation Date											^			

#### **Method to Identify Change:**

Traceability code

#### **Qualification Report:**

Please open the attachments included with this PCN labeled as PCN # Qual Report.

#### **Revision History:**

November 12, 2019: Issued initial notification

**December 9, 2019:** Issued final notification. Attached the Qualification Report. Provided estimated first ship date to be on January 9, 2020.

The change described in this PCN does not alter Microchip's current regulatory compliance regarding the material content of the applicable products.



#### Attachment(s):

PCN RMES-22VSYL025 QUAL REPORT.pdf
PCN RMES-22VSYL025 PRE AND POST CHANGE.pdf

Please contact your local <u>Microchip sales office</u> with questions or concerns regarding this notification.

#### **Terms and Conditions:**

If you wish to <u>receive Microchip PCNs via email</u> please register for our PCN email service at our <u>PCN home page</u> select register then fill in the required fields. You will find instructions about registering for Microchips PCN email service in the <u>PCN FAQ</u> section.

If you wish to <u>change your PCN profile</u>, <u>including opt out</u>, please go to the <u>PCN home page</u> select login and sign into your myMicrochip account. Select a profile option from the left navigation bar and make the applicable selections.

RMES-22VSYL025 - CCB 3007.002 Final Notice: Qualification of MPHL as an additional Final Test site for selected Atmel ATSAMR30E18A and ATSAMR30G18A device families.

Affected Catalog Part Numbers (CPN)

ATSAMR30E18A-MU ATSAMR30E18A-MUT ATSAMR30E18A-MUT ATSAMR30E18A-MUTA0 ATSAMR30G18A-MU ATSAMR30G18A-MUA0 ATSAMR30G18A-MUT

ATSAMR30G18A-MUTA0

Date: Sunday, December 08, 2019





PCN#: RMES-22VSYL025 CCB 3007.002\_ Pre and Post Changes Summary For selected Atmel ATSAMR30E18A and ATSAMR30G18A device families



# PRE AND POST CHANGE (TRAY)

Packing Media	ITEM	ASE	MPHL
	Base Quantity Multiple (BQM)	416	416
	Tray dimension	No change	No change
	Tray Stack	10+1	10+1
Tray	Tray	Bakeable (150°C)	Bakeable (150°C)
	Pin 1 Orientation	Pin 1 identifier	MPHIL Packing Specification  All Packages except TSOP  Tray chamfer  Pin 1 identifier



## **Moisture Barrier Bag – Tray**

A	SE	M	PHL
Length (mm)	Width (mm)	Length (mm)	Width (mm)
510 mm	280 mm	482.6 mm	228.6 mm

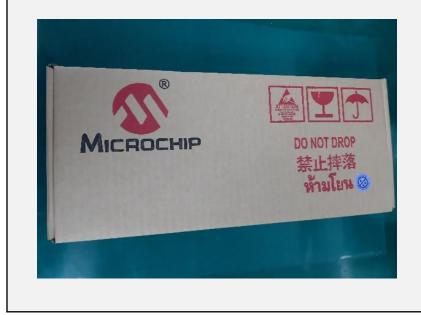






## **Carton Box – Tray**

ASE				MPHL	
Length (mm)	Width (mm)	Height (mm)	Length (mm)	Width (mm)	Height (mm)
371.5 mm	162 mm	88 mm	371.5 mm	162 mm	88 mm







# PRE AND POST CHANGE (Tape and Reel)

Packing Media	ITEM	ASE	MPHL
	Base Quantity Multiple (BQM)	4000	4000
Tape and Reel	Pin 1 Orientation	Position of Pin 1	Position of Pin 1



# **Packing Information – Tape and Reel**

Packing Information	Final Test Site	Width	Pitch	Ao (mm)	Bo (mm)	Ko (mm)
Carrier Tape	ASE	12 mm	8 mm	5.25 ±0.1 mm	5.25 ±0.1 mm	1.1 ±0.1 mm
Dimension	MPHL	12 mm	12 mm	7.25 ±0.1 mm	7.25 ±0.1 mm	1.1 ±0.1 mm



## **Plastic reel**

ASE	MPHL
MCHP STD Label Carrier Tape & Cover Tape  Protective Band Reel Label	MCHP STD Label Carrier Tape & Cover Tape  Protective Band Reel Label

PLANT	Reel Diameter	Hub diameter	W1 +0.3-0	W2 Max	Color
ASE	330 mm	102 mm	16.8 +0.3-0	22.2	White
MPHL	328 – 332 mm	100 – 102 mm	16.4 - 18.4 +0.3-0	22.4	Dark Blue



## **Desiccant – Tape and Reel**





# **Moisture Barrier Bag – Tape and Reel**

A	SE	M	PHL
Length (mm)	Width (mm)	Length (mm)	Width (mm)
495 mm	430 mm	457.2 mm	406.4 mm







# **Carton Box – Tape and Reel**

ASE			MPHL		
Length (mm)	Width (mm)	Height (mm)	Length (mm)	Width (mm)	Height (mm)
354 mm	352 mm	53 mm	354 mm	352 mm	53 mm







### **QUALIFICATION REPORT SUMMARY**

PCN #: RMES-22VSYL025

Date: November 25, 2019

Qualification of MPHL as an additional Final Test site for selected Atmel ATSAMR30E18A and ATSAMR30G18A device families.

Purpose: Qualification of MPHL as an additional Final Test site for

selected Atmel ATSAMR30E18A and ATSAMR30G18A

device families.

CCB No.: 3007.002

Test / Evaluation	Test Conditions / Parameters	Result
Lot Correlation	1 qualification lots with 3, 000 units at currently qualified test site (original site) and new test site (destination site) for both ATSAMR30E18A and ATSAMR30G18A device families from ASE to MPHL	Pass
Parametric Data Comparison	33 units of parametric data comparison	Pass
Datalog / Bin Comparison	<ul> <li>3,000 units yield sample for bin comparison ASE and MPHL</li> <li>The yield difference should be within 0.1% and bin-to- bin difference should be within 0.1%</li> </ul>	Pass